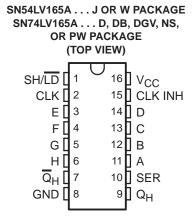
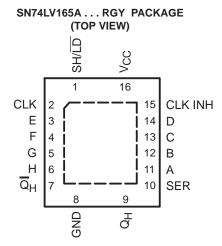
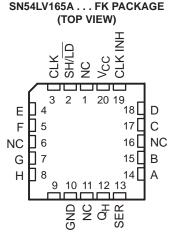
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- 2-V to 5.5-V V<sub>CC</sub> Operation
- Max t<sub>pd</sub> of 10.5 ns at 5 V
- Support Mixed-Mode Voltage Operation on All Ports
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)







NC - No internal connection

### description/ordering information

The 'LV165A devices are parallel-load, 8-bit shift registers designed for 2-V to 5.5-V  $V_{CC}$  operation.

When the devices are clocked, data is shifted toward the serial output  $Q_H$ . Parallel-in access to each stage is provided by eight individual direct data inputs that are enabled by a low level at the shift/load (SH/ $\overline{LD}$ ) input. The 'LV165A devices feature a clock-inhibit function and a complemented serial output,  $\overline{Q}_H$ .

#### ORDERING INFORMATION

т <sub>А</sub>	PACK	AGE <sup>†</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	QFN – RGY	Reel of 1000	SN74LV165ARGYR	LV165A
	2010 5	Tube of 40	SN74LV165AD	11/4054
	SOIC - D	Reel of 2500	SN74LV165ADR	LV165A
	SOP - NS	Reel of 2000	SN74LV165ANSR	74LV165A
-40°C to 85°C	SSOP – DB	Reel of 2000	SN74LV165ADBR	LV165A
		Tube of 90	SN74LV165APW	
	TSSOP - PW	Reel of 2000	SN74LV165APWR	LV165A
		Reel of 250	SN74LV165APWT	
	TVSOP - DGV	Reel of 2000	SN74LV165ADGVR	LV165A
_	CDIP – J	Tube of 25	SNJ54LV165AJ	SNJ54LV165AJ
-55°C to 125°C	CFP – W	Tube of 150	SNJ54LV165AW	SNJ54LV165AW
	LCCC - FK	Tube of 55	SNJ54LV165AFK	SNJ54LV165AFK

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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### description/ordering information (continued)

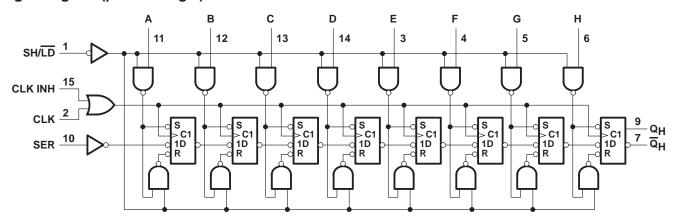
Clocking is accomplished by a low-to-high transition of the clock (CLK) input while  $SH/\overline{LD}$  is held high and clock inhibit (CLK INH) is held low. The functions of CLK and CLK INH are interchangeable. Since a low CLK and a low-to-high transition of CLK INH accomplishes clocking, CLK INH should be changed to the high level only while CLK is high. Parallel loading is inhibited when  $SH/\overline{LD}$  is held high. The parallel inputs to the register are enabled while  $SH/\overline{LD}$  is held low, independently of the levels of CLK, CLK INH, or SER.

These devices are fully specified for partial-power-down applications using  $I_{\text{off}}$ . The  $I_{\text{off}}$  circuitry disables the outputs, preventing damaging current backflow through the devices when they are powered down.

**FUNCTION TABLE** 

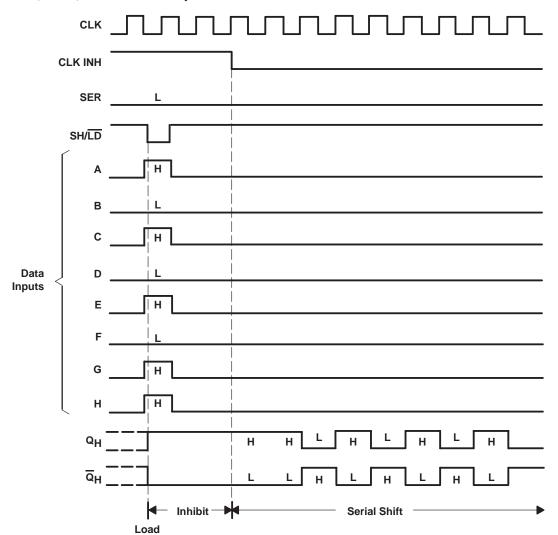
	INPUT	S	ODED ATION
SH/LD	CLK	CLK INH	OPERATION
L	Χ	Χ	Parallel load
Н	Н	Χ	$Q_0$
Н	Χ	Н	$Q_0$
Н	L	$\uparrow$	Shift
Н	$\uparrow$	L	Shift

#### logic diagram (positive logic)



Pin numbers shown are for the D, DB, DGV, J, NS, PW, RGY, and W packages.

## typical shift, load, and inhibit sequences



# SN54LV165A, SN74LV165A PARALLEL-LOAD 8-BIT SHIFT REGISTERS

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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	–0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)	
Voltage range applied to any output in the high-impedance	
or power-off state, V <sub>O</sub> (see Note 1)	0.5 V to 7 V
Output voltage range, V <sub>O</sub> (see Notes 1 and 2)	
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	–50 mA
Continuous output current, $I_O$ ( $V_O = 0$ to $V_{CC}$ )	±25 mA
Continuous current through V <sub>CC</sub> or GND	
Package thermal impedance, θ <sub>JA</sub> (see Note 3): D package	73°C/W
(see Note 3): DB package	82°C/W
(see Note 3): DGV package	120°C/W
(see Note 3): NS package	67°C/W
(see Note 3): PW package	108°C/W
(see Note 4): RGY package	39°C/W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

- 2. This value is limited to 5.5 V maximum.
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.
- 4. The package thermal impedance is calculated in accordance with JESD 51-5.



## recommended operating conditions (see Note 5)

			SN54L	V165A	SN74L	V165A	
			MIN	MAX	MIN	MAX	UNIT
Vcc	Supply voltage		2	5.5	2	5.5	V
		V <sub>CC</sub> = 2 V	1.5		1.5		
.,	Lifeth Java Canada adhana	V <sub>CC</sub> = 2.3 V to 2.7 V	V <sub>CC</sub> ×0.7		V <sub>CC</sub> ×0.7		V
VIH	High-level input voltage	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$	$V_{CC} \times 0.7$		$V_{CC} \times 0.7$		V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	$V_{CC} \times 0.7$		$V_{CC} \times 0.7$		
		V <sub>CC</sub> = 2 V		0.5		0.5	
V.	Low level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	V
$V_{IL}$	Low-level input voltage	V <sub>CC</sub> = 3 V to 3.6 V		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	V
		V <sub>CC</sub> = 4.5 V to 5.5 V		$V_{CC} \times 0.3$		$V_{CC} \times 0.3$	
VI	Input voltage		0	5.5	0	5.5	V
VO	Output voltage		0	Vcc	0	VCC	V
		V <sub>CC</sub> = 2 V	S	-50		-50	μΑ
	Library and and an extensión an extensión and an extensión an extensión ana extensión an extensión ana extensión an extensión a	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	90	-2		-2	
ЮН	High-level output current	V <sub>CC</sub> = 3 V to 3.6 V	Q	-6		-6	mA
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		-12		-12	
		V <sub>CC</sub> = 2 V		50		50	μΑ
1	Law law law at autout assument	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		2		2	
lOL	Low-level output current	$V_{CC} = 3 V \text{ to } 3.6 V$		6		6	mA
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		12		12	
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		200		200	
Δt/Δν	Input transition rise or fall rate	$V_{CC} = 3 V \text{ to } 3.6 V$		100		100	ns/V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		20		20	
$T_A$	Operating free-air temperature		-55	125	-40	85	°C

NOTE 5: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

242445752	TEST SOMBITIONS	.,	SN54	LV165A		SN74	LV165A	1	
PARAMETER	TEST CONDITIONS	VCC	MIN	TYP I	MAX	MIN	TYP	MAX	UNIT
	I <sub>OH</sub> = -50 μA	2 V to 5.5 V	V <sub>CC</sub> -0.1			V <sub>CC</sub> -0.1			
	$I_{OH} = -2 \text{ mA}$	2.3 V	2			2			.,
Voн	I <sub>OH</sub> = -6 mA	3 V	2.48			2.48			V
	I <sub>OH</sub> = -12 mA	4.5 V	3.8	14		3.8			
	I <sub>OL</sub> = 50 μA	2 V to 5.5 V		KI	0.1			0.1	
V	I <sub>OL</sub> = 2 mA	2.3 V		Q	0.4			0.4	V
VOL	I <sub>OL</sub> = 6 mA	3 V	\$	5	0.44			0.44	V
	I <sub>OL</sub> = 12 mA	4.5 V	90		0.55			0.55	
lį	V <sub>I</sub> = 5.5 V or GND	0 to 5.5 V	Q'		±1			±1	μΑ
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			20			20	μΑ
l <sub>off</sub>	$V_I$ or $V_O = 0$ to 5.5 $V$	0			5			5	μΑ
Ci	V <sub>I</sub> = V <sub>CC</sub> or GND	3.3 V		1.7		_	1.7	·	pF

# SN54LV165A, SN74LV165A PARALLEL-LOAD 8-BIT SHIFT REGISTERS

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# timing requirements over recommended operating free-air temperature range, $V_{CC}$ = 2.5 V $\pm$ 0.2 V (unless otherwise noted) (see Figure 1)

			T <sub>A</sub> = 1	25°C	SN54LV	/165A	SN74L\	/165A	
			MIN	MAX	MIN	MAX	MIN	MAX	UNIT
_	Dulas direction	CLK high or low	8.5		9		9		
t <sub>W</sub>	Pulse duration	SH/LD low	11		13	3	13		ns
		SH/LD high before CLK↑	7		8.5	NA	8.5		
١.	Catura tima	SER before CLK↑	8.5		9.5	N. A.	9.5		
tsu	Setup time	CLK INH before CLK↑	7		7.		7		ns
		Data before SH/LD↑	11.5		12		12		
		SER data after CLK↑	-1		00		0		
th	Hold time	Parallel data after SH/LD↑	0		0.5		0.5		ns
		SH/LD high after CLK↑	0		0		0		

# timing requirements over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V $\pm$ 0.3 V (unless otherwise noted) (see Figure 1)

			T <sub>A</sub> = 1	25°C	SN54L	V165A	SN74L\	/165A	
			MIN	MAX	MIN	MAX	MIN	MAX	UNIT
	Delega demotion	CLK high or low	6		7		7		
t <sub>W</sub>	Pulse duration	SH/LD low	7.5		9	3	9		ns
		SH/LD high before CLK↑	5		6	NA	6		
	Oathur Cara	SER before CLK↑	5		6	75	6		
t <sub>su</sub>	Setup time	CLK INH before CLK↑	5		5/		5		ns
		Data before SH/LD↑	7.5		8.5		8.5		
		SER data after CLK↑	0		00		0		
th	Hold time	Parallel data after SH/LD↑	0.5		0.5		0.5		ns
		SH/LD high after CLK↑	0		0		0		

# timing requirements over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

			T <sub>A</sub> = 2	25°C	SN54L	V165A	SN74L\	/165A	
			MIN	MAX	MIN	MAX	MIN	MAX	UNIT
	Dulas direction	CLK high or low	4		4		4		
t <sub>W</sub>	Pulse duration	SH/LD low	5		6	3	6		ns
		SH/LD high before CLK↑	4		4	Z	4		
١.	Catura tima	SER before CLK↑	4		4	BA	4		
tsu	Setup time	CLK INH before CLK↑	3.5		3.5		3.5		ns
		Data before SH/LD↑	5		55		5		
		SER data after CLK↑	0.5		0.5		0.5		
th	Hold time	Parallel data after SH/LD↑	1		Q 1		1		ns
		SH/LD high after CLK↑	0.5		0.5		0.5		

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# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 2.5 V $\pm$ 0.2 V (unless otherwise noted) (see Figure 1)

DADAMETER	FROM	то	LOAD	T,	<sub>A</sub> = 25°C	;	SN54L	V165A	SN74L\	/165A	
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			C <sub>L</sub> = 15 pF	50*	80*		45*		45		MHz
fmax			C <sub>L</sub> = 50 pF	40	65		35	14	35		IVIHZ
	CLK				12.2*	19.8*	1*	22*	1	22	
t <sub>pd</sub>	SH/LD	$Q_H$ or $\overline{Q}_H$	C <sub>L</sub> = 15 pF		13.1*	21.5*	1*,4	23.5*	1	23.5	ns
	Н				12.9*	21.7*	15	24*	1	24	
	CLK				15.3	23.3	Q <sub>1</sub>	26	1	26	
t <sub>pd</sub>	SH/LD	$Q_H$ or $\overline{Q}_H$	C <sub>L</sub> = 50 pF		16.1	25.1	2 1	28	1	28	ns
	Н				15.9	25.3	1	28	1	28	

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 3.3 V $\pm$ 0.3 V (unless otherwise noted) (see Figure 1)

DADAMETED	FROM	то	LOAD	T,	4 = 25°C	;	SN54L\	/165A	SN74L	/165A	
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			C <sub>L</sub> = 15 pF	65*	115*		55*		55		MHz
f <sub>max</sub>			C <sub>L</sub> = 50 pF	60	90		50	151	50		IVIHZ
	CLK				8.6*	15.4*	1*	18*	1	18	
<sup>t</sup> pd	SH/LD	$Q_H$ or $\overline{Q}_H$	C <sub>L</sub> = 15 pF		9.1*	15.8*	1*,4	18.5*	1	18.5	ns
·	Н				8.9*	14.1*	1.5	16.5*	1	16.5	
	CLK				10.9	14.9	Q1	16.9	1	16.9	
<sup>t</sup> pd	SH/LD	$Q_H$ or $\overline{Q}_H$	C <sub>L</sub> = 50 pF		11.3	19.3	2 1	22	1	22	ns
	Н				11.1	17.6	1	20	1	20	

<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

	` `			<u> </u>	,						
	FROM	то	LOAD	T	Δ = 25°C	;	SN54L	/165A	SN74L	/165A	
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
			C <sub>L</sub> = 15 pF	110*	165*		90*	4	90		N 41 1-
f <sub>max</sub>			C <sub>L</sub> = 50 pF	95	125		85	(E)	85		MHz
	CLK				6*	9.9*	1*	11.5*	1	11.5	
t <sub>pd</sub>	SH/LD	$Q_H$ or $\overline{Q}_H$	C <sub>L</sub> = 15 pF		6*	9.9*	1*,4	11.5*	1	11.5	ns
·	Н				6*	9*	10	10.5*	1	10.5	
	CLK				7.7	11.9	)Q	13.5	1	13.5	
<sup>t</sup> pd	SH/LD	$Q_H$ or $\overline{Q}_H$	C <sub>L</sub> = 50 pF		7.7	11.9	Q 1	13.5	1	13.5	ns
	Н				7.6	11	1	12.5	1	12.5	

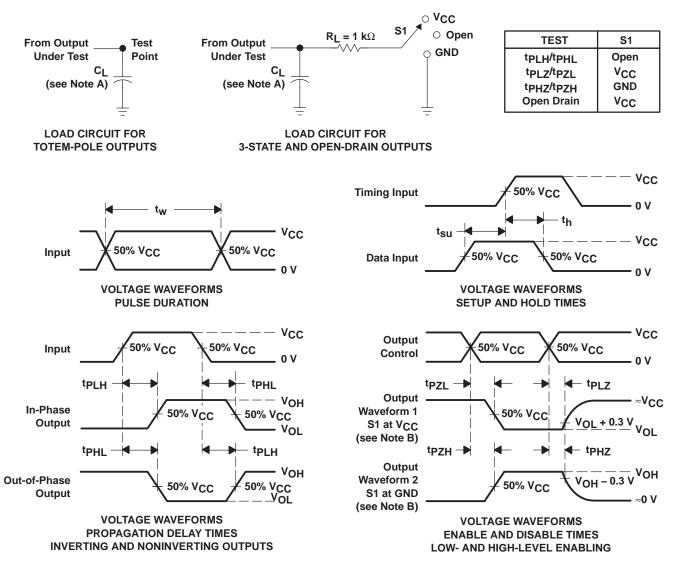
<sup>\*</sup> On products compliant to MIL-PRF-38535, this parameter is not production tested.

## operating characteristics, T<sub>A</sub> = 25°C

	PARAMETER		TEST CONDITIONS			UNIT
<u> </u>	Dayler discination conscitones	C. F0 pF	f 40 MH-	3.3 V	36.1	PF
Cpd	Power dissipation capacitance	$C_L = 50 pF$ ,	f = 10 MHz	5 V	37.5	рF



#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- All input pulses are supplied by generators having the following characteristics:  $PRR \le 1 \text{ MHz}$ ,  $Z_O = 50 \Omega$ ,  $t_f \le 3 \text{ ns}$ ,  $t_f \le 3 \text{ ns}$ .
- D. The outputs are measured one at a time, with one input transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F. tpz and tpzH are the same as ten.
- G. tpHL and tpLH are the same as tpd.
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms









### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN74LV165AD	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165ADBR	ACTIVE	SSOP	DB	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165ADBRE4	ACTIVE	SSOP	DB	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165ADE4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165ADGVR	ACTIVE	TVSOP	DGV	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165ADGVRE4	ACTIVE	TVSOP	DGV	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165ADR	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165ADRE4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165ANSR	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165ANSRE4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165APW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165APWE4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165APWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165APWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165APWRE4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165APWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165APWT	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165APWTE4	ACTIVE	TSSOP	PW	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LV165ARGYR	ACTIVE	QFN	RGY	16	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR
SN74LV165ARGYRG4	ACTIVE	QFN	RGY	16	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1YEAR

(1) The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available. **OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



#### PACKAGE OPTION ADDENDUM

18-Jul-2006

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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## DGV (R-PDSO-G\*\*)

#### **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

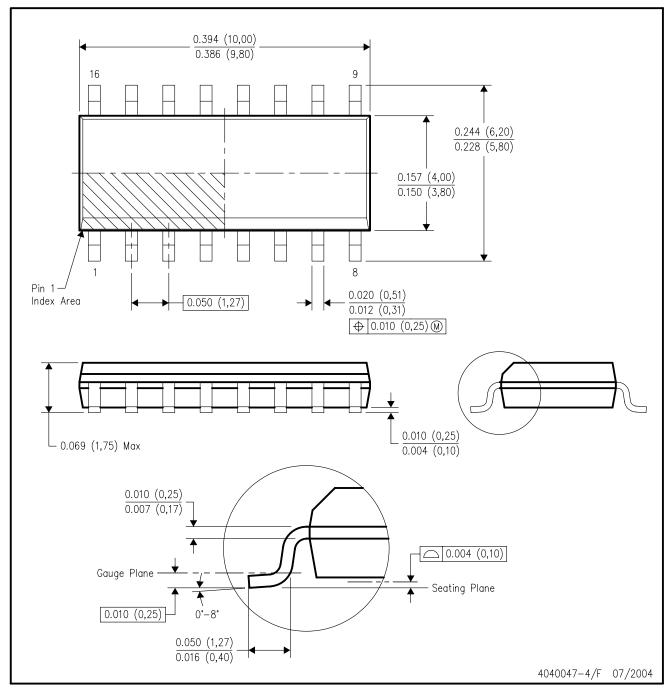
C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194



# D (R-PDSO-G16)

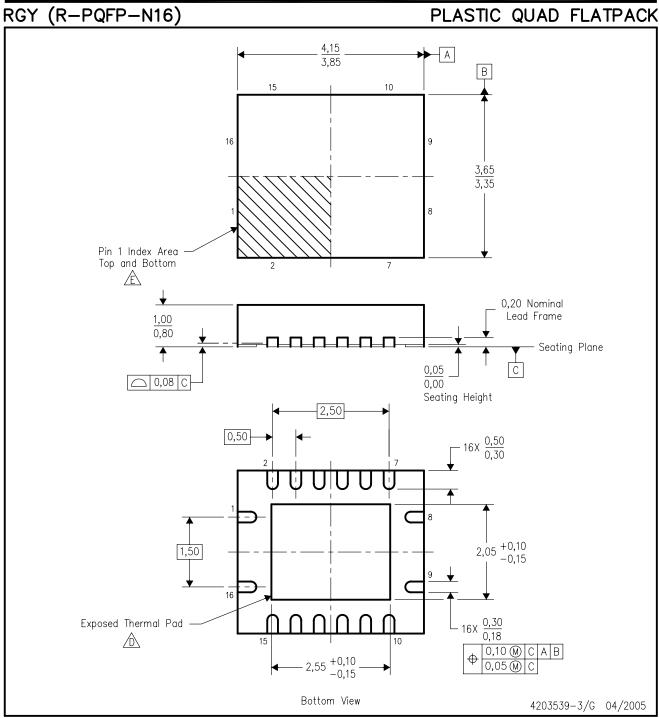
# PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AC.





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- The package thermal pad must be soldered to the board for thermal and mechanical performance.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- F. Package complies to JEDEC MO-241 variation BB.



## **MECHANICAL DATA**

# NS (R-PDSO-G\*\*)

# 14-PINS SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



## DB (R-PDSO-G\*\*)

## PLASTIC SMALL-OUTLINE

#### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150

## PW (R-PDSO-G\*\*)

#### 14 PINS SHOWN

## PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

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